

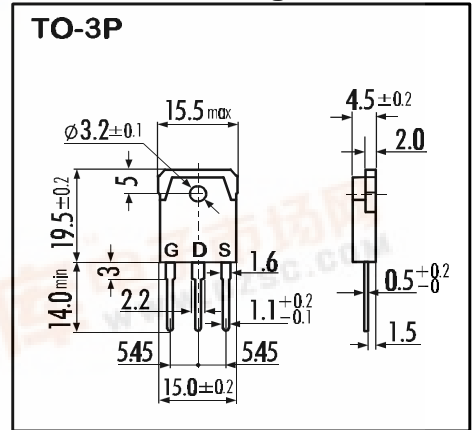
> Features

- High Current
- Low On-Resistance
- No Secondary Breakdown
- Low Driving Power
- Avalanche Rated

> Applications

- Motor Control
- General Purpose Power Amplifier
- DC-DC converters

> Outline Drawing



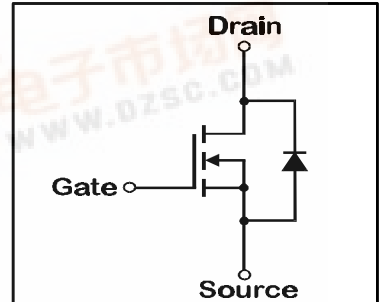
> Maximum Ratings and Characteristics

- Absolute Maximum Ratings (T_C=25°C), unless otherwise specified

Item	Symbol	Rating	Unit
Drain-Source-Voltage	V _{DS}	60	V
Continous Drain Current	I _D	80	A
Pulsed Drain Current	I _{D(puls)}	320	A
Gate-Source-Voltage	V _{GS}	±20	V
Maximum Avalanche Energy	E _{AV}	599	mJ*
Max. Power Dissipation	P _D	125	W
Operating and Storage Temperature Range	T _{ch}	150	°C
	T _{stg}	-55 ~ +150	°C

* L=0,125mH, V_{CC}=24V

> Equivalent Circuit



- Electrical Characteristics (T_C=25°C), unless otherwise specified

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit	
Drain-Source Breakdown-Voltage	V _{(BR)DSS}	I _D =1mA V _{GS} =0V	60			V	
Gate Threshold Voltage	V _{GS(th)}	I _D =1mA V _{DS} =V _{GS}	1,0	1,5	2,0	V	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V V _{GS} =0V	T _{ch} =25°C		10	500	μA
			T _{ch} =125°C		0,2	1,0	mA
Gate Source Leakage Current	I _{GSS}	V _{GS} =±20V V _{DS} =0V		10	100	nA	
Drain Source On-State Resistance	R _{DS(on)}	I _D =40A	V _{GS} =4V		0,012	0,017	Ω
			V _{GS} =10V		0,0075	0,01	Ω
Forward Transconductance	g _{fs}	I _D =40A V _{DS} =25V	25	55		S	
Input Capacitance	C _{iss}	V _{DS} =25V		3500	5250	pF	
Output Capacitance	C _{oss}	V _{GS} =0V		1250	1870	pF	
Reverse Transfer Capacitance	C _{rss}	f=1MHz		360	540	pF	
Turn-On-Time t _{on} (t _{on} =t _{d(on)} +t _r)	t _{d(on)}	V _{CC} =30V I _D =75A		15	23	ns	
				75	120	ns	
Turn-Off-Time t _{off} (t _{off} =t _{d(off)} +t _f)	t _{d(off)}	V _{GS} =10V R _{GS} =10 Ω		190	285	ns	
			t _f	110	165	ns	
Avalanche Capability	I _{AV}	L = 100μH T _{ch} =25°C	80			A	
Diode Forward On-Voltage	V _{SD}	I _F =160A V _{GS} =0V T _{ch} =25°C		1,15	1,65	V	
Reverse Recovery Time	t _{rr}	I _F =80A V _{GS} =0V		75	120	ns	
Reverse Recovery Charge	Q _{rr}	-di _F /dt=100A/μs T _{ch} =25°C		0,17		μC	

- Thermal Characteristics

Item	Symbol	Test conditions	Min.	Typ.	Max.	Unit
Thermal Resistance	R _{th(ch-a)}	channel to air			35	°C/W
	R _{th(ch-c)}	channel to case			1,0	°C/W



N-channel MOS-FET			
60V	0,01Ω	80A	125W

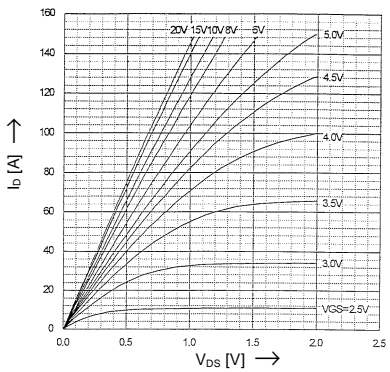
2SK2690-01

FAP-III B Series

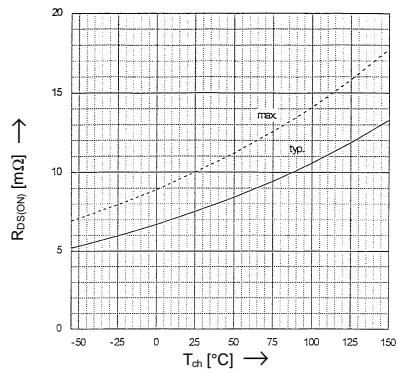


> Characteristics

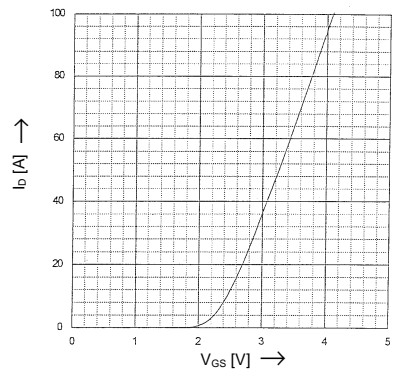
Typical Output Characteristics
 $I_D = f(V_{DS})$; 80μs pulse test; $T_{ch} = 25^\circ\text{C}$



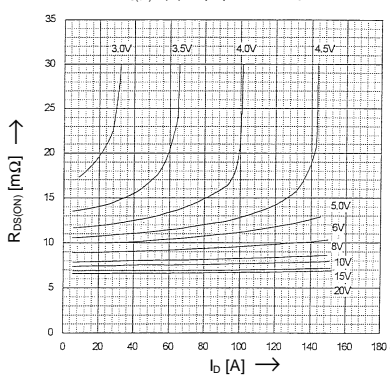
Drain-Source On-State Resistance vs. T_{ch}
 $R_{DS(on)} = f(T_{ch})$; $I_D = 40\text{A}$; $V_{GS} = 10\text{V}$



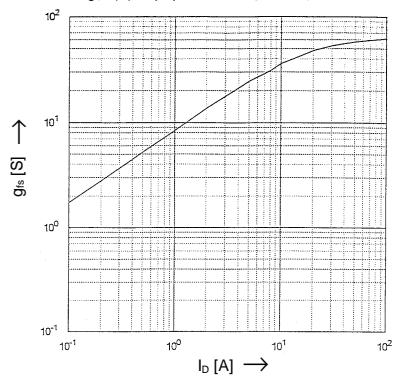
Typical Transfer Characteristics
 $I_D = f(V_{GS})$; 80μs pulse test; $V_{DS} = 25\text{V}$; $T_{ch} = 25^\circ\text{C}$



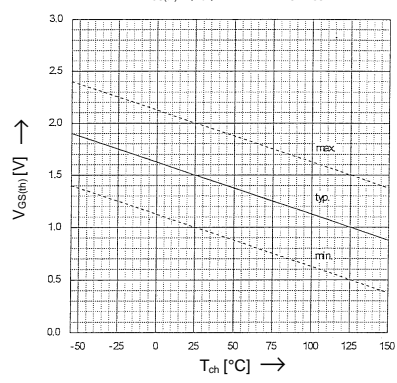
Typical Drain-Source On-State-Resistance vs. I_D
 $R_{DS(on)} = f(I_D)$; 80μs pulse test; $T_{ch} = 25^\circ\text{C}$



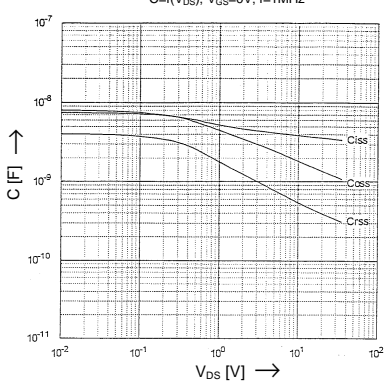
Typical Forward Transconductance vs. I_D
 $g_{fs} = f(I_D)$; 80μs pulse test; $V_{DS} = 25\text{V}$; $T_{ch} = 25^\circ\text{C}$



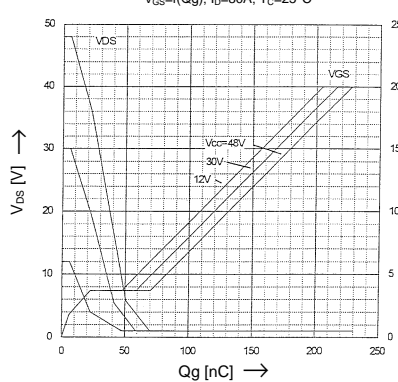
Gate Threshold Voltage vs. T_{ch}
 $V_{GS(th)} = f(T_{ch})$; $I_D = 1\text{mA}$; $V_{DS} = V_{GS}$



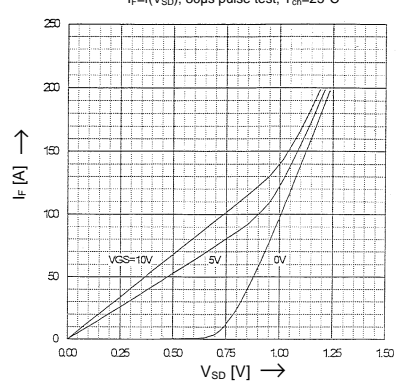
Typical Capacitances vs. V_{DS}
 $C = f(V_{DS})$; $V_{GS} = 0\text{V}$; $f = 1\text{MHz}$



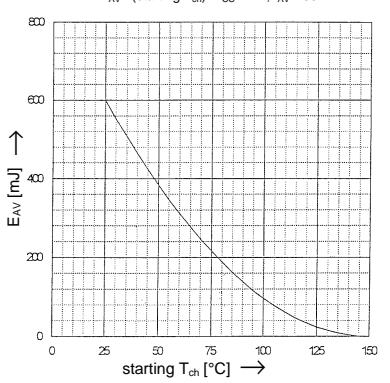
Typical Gate Charge Characteristic
 $V_{GS} = f(Q_g)$; $I_D = 80\text{A}$; $T_{ch} = 25^\circ\text{C}$



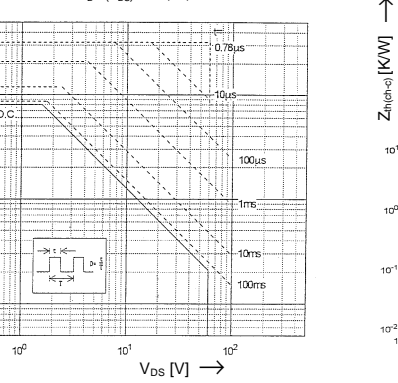
Forward Characteristics of Reverse Diode
 $I_F = f(V_{SD})$; 80μs pulse test; $T_{ch} = 25^\circ\text{C}$



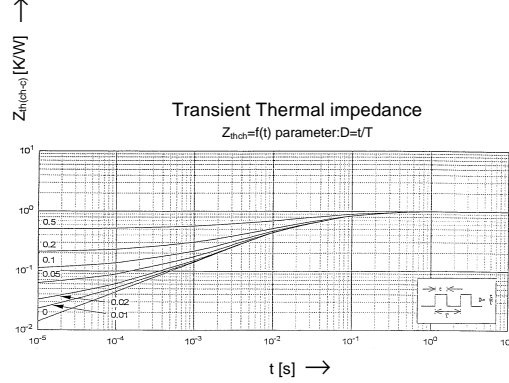
Maximum Avalanche Energy vs. starting T_{ch}
 $E_{AV} = f(\text{starting } T_{ch})$; $V_{OC} = 24\text{V}$; $I_{AV} \leq 80\text{A}$



Safe Operation Area
 $I_D = f(V_{DS})$; $D = 0,01$; $T_{ch} = 25^\circ\text{C}$



Transient Thermal Impedance
 $Z_{th(j-c)} = f(t)$ parameter: $D = t/T$



N-channel MOS-FET			
60V	0,01Ω	80A	125W

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FAP-III B Series



> Characteristics

